Search Notes

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Daniel Kim

Applicant(s)/Patent un	der
Reexamination	

LEE ET AL.

Art Unit

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SEARCHED			
Class	Subclass	Date	Examiner
711	100, 101	3/22/2007	DK
711	115	3/22/2007	DK
710	5, 6	3/22/2007	DK
710	58, 305	3/22/2007	DK
439	631	3/22/2007	, DK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
711	115	3/22/2007	DK
US PGPt	ub Search	3/22/2007	DK

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Updated EAST Search	3/22/2007	DK
Inventor Name Search for DP	3/22/2007	DK
IEEE Search	3/22/2007	DK
ACM Search	3/22/2007	DK
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